Compliant with IEC 62474/ D9.00 Compliant to IEC 61249-2-21:2003

CROCHIP Semiconductor Device Type:	so	SO (F2X) 018 SOIC .300in Matte Tin		Termination Base Alloy: Copper Alloy (Cu)			Package Homogeneous Materials: 8.1 Electronics (e.g. pc boards, displays)			
Basic Substance	CAS Number	"Contained In" Sub-Component	% Total Weight	mg/part	ppm	383.84	(mg) Total	Mold Compound	% ot Total Weight	79.8
Silica, vitreous	60676-86-0	Mold Compound	67.830	326,262	678.300		Silica, vitreous	60676-86-0	85.00	
Epoxy Resin (No bromine, No diantimony trioxide)	Trade Secret	Mold Compound	4.888	23.510	48,878		Epoxy Resin	Trade Secret	6.13	
Phenolic Resin (No Br / CL SbO3, No diantimony trioxide)	Trade Secret	Mold Compound	4.888	23.510	48,878		Phenolic Resin	Trade Secret	6.13	
Epoxy, Cresol Novolac	29690-82-2	Mold Compound	1.955	9.404	19,551		Epoxy, Cresol Novolac	29690-82-2	2.45	
Carbon Black	1333-86-4	Mold Compound	0.239	1.152	2,394		Carbon Black	1333-86-4	0.30	
Copper	7440-50-8	Lead Frame	10.031	48.251	100,314			Total	100.00	
Iron	7439-89-6	Lead Frame	0.247	1.187	2,468	50.51	(mg) Total	Lead Frame	% of Total Weight	10.5
Silver	7440-22-4	Lead Frame	0.200	0.962	2,000		Copper	7440-50-8	95.54	
Zinc	7440-66-6	Lead Frame	0.013	0.063	131		Iron	7439-89-6	2.35	
Phosphorous	7723-14-0	Lead Frame	0.009	0.042	87		Silver	7440-22-4	1.91	
Silver (Ag)	7440-22-4	Die Attach	0.563	2.706	5,625		Zinc	7440-66-6	0.13	
Modified Epoxy Resin	13561-08-5	Die Attach	0.105	0.505	1,050		Phosphorous	7723-14-0	0.08	
Diglycidylether of bisphenol-F	54208-63-8	Die Attach	0.056	0.271	563			Total	100.00	
Modified Amine	827-43-0	Die Attach	0.026	0.126	263	3.61	(mg) Total	Die Attach	% of Total Weight	0.75
Silicon	7440-21-3	Chip (Die)	7.500	36.075	75.000		Silver (Ag)	7440-22-4	75.00	
Gold	7440-57-5	Wire Bond	0.200	0.962	2.000		Modified Epoxy Resin	13561-08-5	14.00	
Tin	7440-31-5	Plating on external leads (pins) - Matte Tin / annealed at 150°C for 1 hour	1.250	6.013	12,500	Dio	lycidylether of bisphenol-F	54208-63-8	7.50	
		TOTALS:	100.000	481.000	1,000,000		Modified Amine	827-43-0	3.50	
	0.4810	q Total Mass						Total	100.00	
								Total	100.00	
emiconductor device and its homogenous materials comply w 2015) and 2002/53/EC (End-of-Life Vehicles (ELV) without exe liance with the above EU Directives has been verified via inter	emption (zero)	: 2002/95/EC (27 January 2003) & Directive 2011/65/EU ((08 June 2011)	and 2015/863	8/EU (31	36.08	Total (mg) Doped Silicon	Chip (Die) 7440-21-3	% of Total Weight	7.5
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Au 1:38 PM : 8/17/2015